# Supporting Information

## Melt-Grown Large-Sized Cs<sub>2</sub>TeI<sub>6</sub> Crystals for X-Ray Detection

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## 1. The calibration of X-ray dose rate.



Fig. S1 The relationship between the dose rate and current of X-ray tube.

# 2. The characterization of photoresponse of Cs<sub>2</sub>TeI<sub>6</sub> crystal.



Fig. S2 Power-dependent ratio of on-off current illuminated by blue light with a wavelength of 425 nm under 100 V.

#### 3. The calculation of signal-to-noise ratio.

As shown in Fig. S3, the signal current  $(I_{signal})$  was derived by subtracting the average photocurrent  $(\overline{I}_{photo})$  by the average dark current  $(\overline{I}_{dark})$ . The noise current  $(I_{noise})$  was obtained by calculating the standard deviation of the photocurrent.

$$I_{signal} = \overline{I}_{photo} - \overline{I}_{dark}$$

$$I_{noise} = \sqrt{\frac{1}{N} \sum_{i}^{N} (I_i - \overline{I}_{photo})^2}$$

Then the signal-to-noise ratio (SNR) was calculated using

For example, for  $Cs_2TeI_6$  device with 5 V bias and under 277.1 nGy·s<sup>-1</sup>, the calculated average photocurrent, dark current, and noise current was 2.243 pA, 1.903 pA, and 0.014 pA, respectively, resulting in a SNR value of 24.3.



Fig. S3. Device response to X-rays (277.1  $nGy \cdot s^{-1}$  dose rate) on tuning the X-ray source on and off.